

Issue Classification



Application/Control No.

10807516

Applicant(s)/Patent under Reexamination

YOUAN, TOYOHICO

Examiner

Coy, Nicole

Art Unit

3672

ORIGINAL

CLASS

175

SUBCLASS

53

CROSS REFERENCE(S)

CLASS

175

406

405

184.1

SUBCLASS (ONE SUBCLASS PER BLOCK)

INTERNATIONAL CLASSIFICATION

CLAIMED

E

2

1

D

1 / 06

NON-CLAIMED

Nicole A. Coy
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6/9/06
(Date)

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Total Claims Allowed:

O.G.
Print Claim(s)

1

O.G.
Print Figure

1